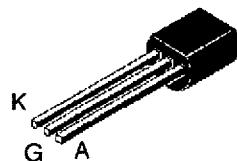


SENSITIVE GATE SCR

FEATURES

- $I_{T(RMS)} = 0.8A$
- $V_{DRM} = 500V$ to $800V$
- Low $I_{GT} \leq 20 \mu A$ max to $< 200 \mu A$



TO92
(Plastic)

DESCRIPTION

The P020xxA series of SCRs uses a high performance planar PNPN technology. These parts are intended for general purpose applications where low gate sensitivity is required.

ABSOLUTE RATINGS (limiting values)

Symbol	Parameter	Value	Unit	
$I_{T(RMS)}$	RMS on-state current (180° conduction angle)	80°C	0.8	A
$I_{T(AV)}$	Mean on-state current (180° conduction angle)	80°C	0.5	A
I_{TSM}	Non repetitive surge peak on-state current (T_j initial = 25°C)	$t_p = 8.3$ ms	8	A
		$t_p = 10$ ms	7	
I^2t	I^2t Value for fusing	$t_p = 10$ ms	0.24	A^2s
dI/dt	Critical rate of rise of on-state current $I_G = 10$ mA $dI/dt = 0.1$ A/ μs .		30	$A/\mu s$
T_{stg} T_j	Storage and operating junction temperature range	- 40, + 150 - 40, + 125	°C	
T_l	Maximum lead temperature for soldering during 10s at 2mm from case	260	°C	

Symbol	Parameter	Voltage				Unit
		E	M	S	N	
V_{DRM} V_{RRM}	Repetitive peak off-state voltage $T_j = 125^\circ C$ $R_{GK} = 1K\Omega$	500	600	700	800	V

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THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
R _{th(j-a)}	Junction to ambient	150	°C/W
R _{th(j-l)}	Junction to leads for DC	60	°C/W

GATE CHARACTERISTICS (maximum values)

P_{G (AV)} = 0.1 W P_{GM} = 2 W (t_p = 20 μs) I_{GM} = 1 A (t_p = 20 μs)

ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions	Sensitivity		Unit	
		01	02		
I _{GT}	V _D =12V (DC) R _L =140Ω	T _j = 25°C	MIN	1	μA
			MAX	20 200	
V _{GT}	V _D =12V (DC) R _L =140Ω	T _j = 25°C	MAX	0.8	V
V _{GD}	V _D =V _{DRM} R _L =3.3kΩ R _{GK} = 1 KΩ	T _j = 125°C	MIN	0.1	V
V _{RGM}	I _{RG} =10μA	T _j = 25°C	TYP	24	V
t _{gd}	V _D =V _{DRM} I _{TM} = 3 x I _{T(AV)} dI _G /dt = 0.1A/μs I _G = 10mA	T _j = 25°C	TYP	0.5	μs
I _H	I _T = 50mA R _{GK} = 1 KΩ	T _j = 25°C	MAX	5	mA
I _L	I _G =1mA R _{GK} = 1 KΩ	T _j = 25°C	MAX	6	mA
V _{TM}	I _{TM} = 1.6A t _p = 380μs	T _j = 25°C	MAX	1.75	V
I _{DRM} I _{RRM}	V _D = V _{DRM} R _{GK} = 1 KΩ V _R = V _{RRM}	T _j = 25°C	MAX	10	μA
		T _j = 125°C	MAX	100	μA
dV/dt	V _D =67%V _{DRM} R _{GK} = 1 KΩ	T _j = 125°C	TYP	100	V/μs
t _q	I _{TM} = 3 x I _{T(AV)} V _R =35V dI/dt=10A/μs t _p =100μs dV/dt=2V/μs V _D = 67%V _{DRM} R _{GK} = 1 KΩ	T _j = 125°C	MAX	200	μs

ORDERING INFORMATION

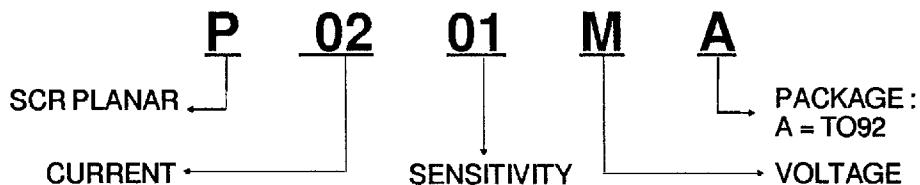


Fig.1 : Maximum average power dissipation versus average on-state current.

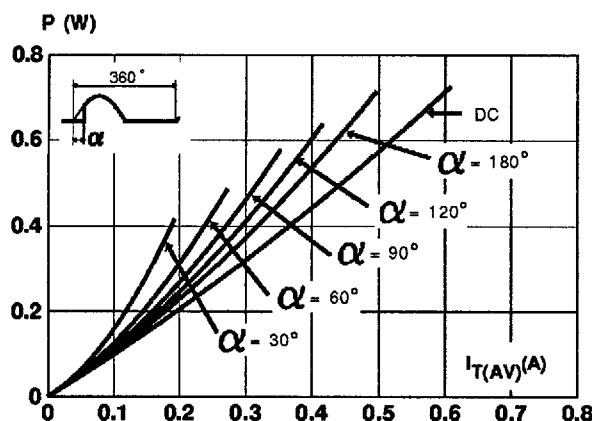


Fig.3 : Average on-state current versus lead temperature.

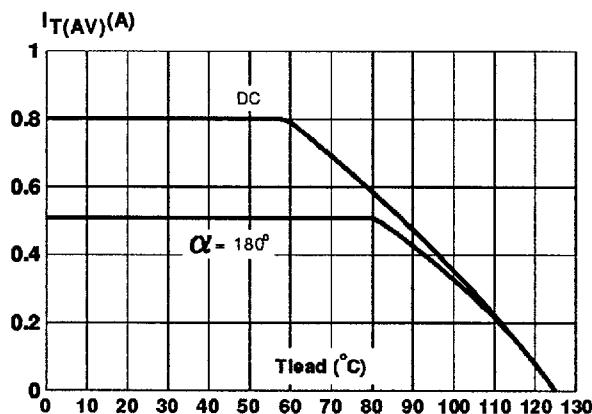


Fig.5 : Relative variation of gate trigger current and holding current versus junction temperature.

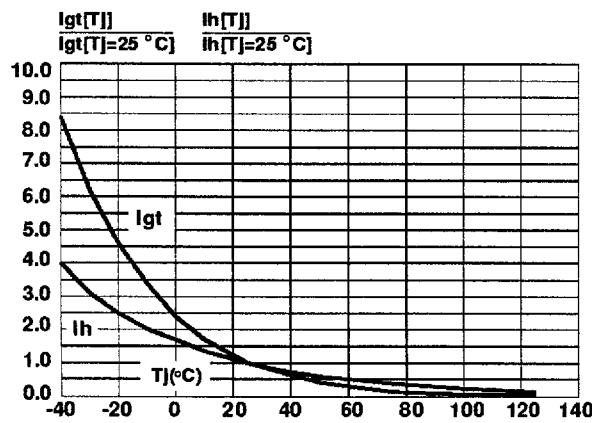


Fig.2 : Correlation between maximum average power dissipation and maximum allowable temperature (Tamb and Tlead).

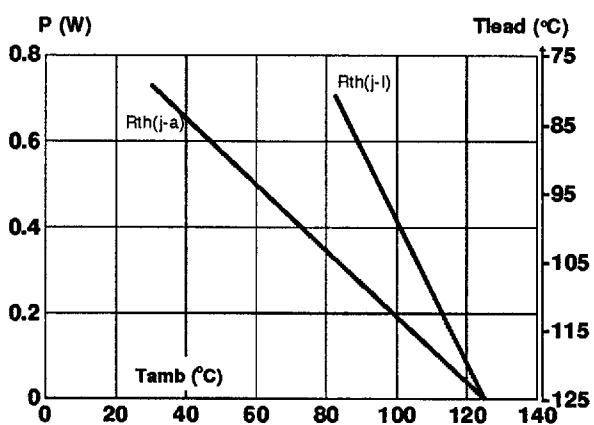


Fig.4 : Relative variation of thermal impedance junction to ambient versus pulse duration.

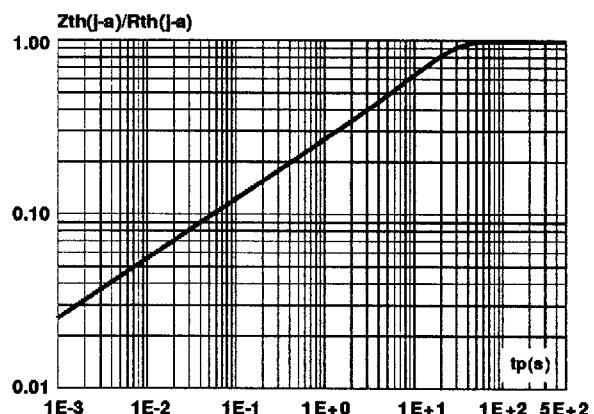
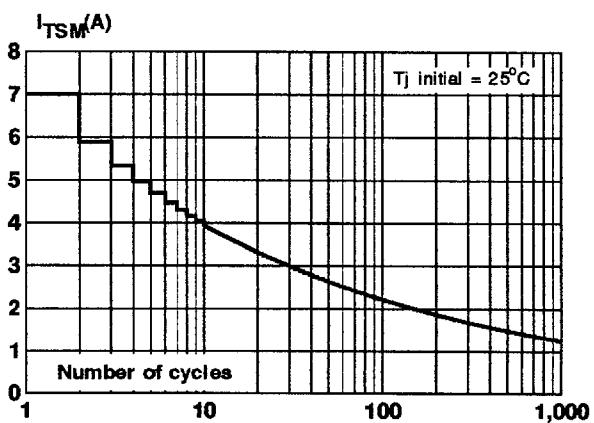


Fig.6 : Non repetitive surge peak on-state current versus number of cycles.



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Fig.7 : Non repetitive surge peak on-state current for a sinusoidal pulse with width : $t_p \leq 10\text{ms}$, and corresponding value of I^2t .

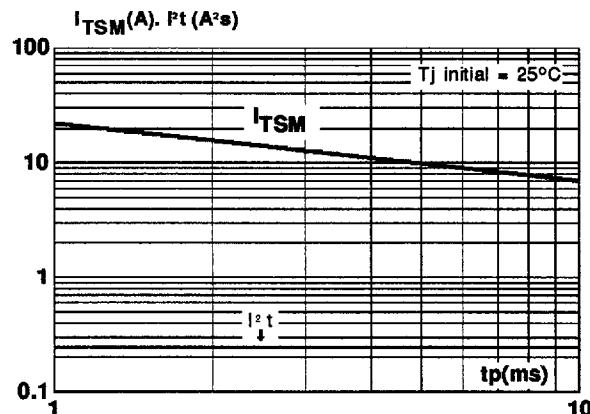


Fig.8 : On-state characteristics (maximum values).

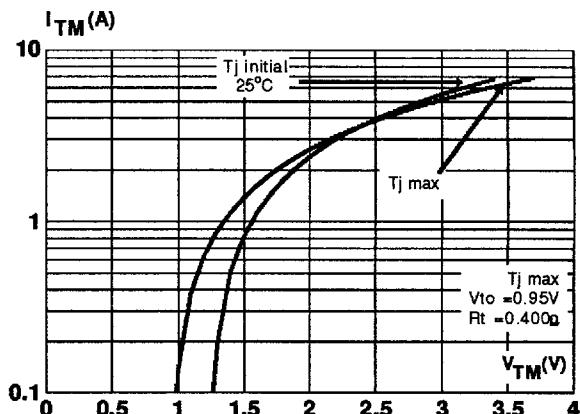
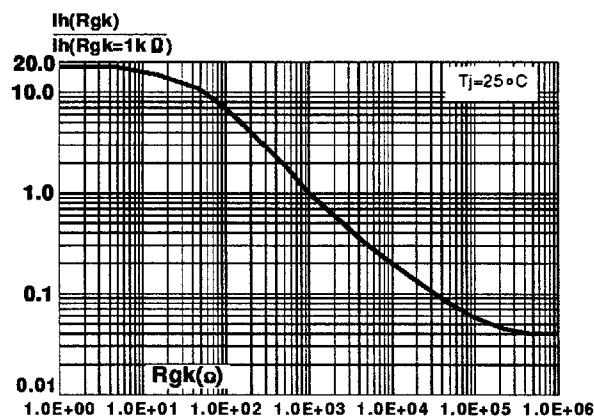


Fig.9 : Relative variation of holding current versus gate-cathode resistance (typical values).



PACKAGE MECHANICAL DATA
TO92 (Plastic)

REF.	DIMENSIONS					
	Millimeters			Inches		
	Typ.	Min.	Max.	Typ.	Min.	Max.
A	1.35			0.053		
B			4.7		0.185	
C	2.54			0.100		
D		4.4	4.8		0.173	0.189
E		12.7			0.500	
F			3.7			0.146
a			0.45			0.017

Marking : Type number
Weight : 0.2 g

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